Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination HOOVEN, MICHAEL D.	
10/038,506		
Examiner	Art Unit	
Victoria W. Chen	3739	

SEARCHED					
Class	Subclass	Date	Examiner		
606	41, 48-52	8/15/2007	vwc		
606	205,207	8/15/2007	vwc		
607	98-99	8/15/2007	wc		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

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